CG65065DAD

Description

CG65065DAD is a 650V GaN-on-Si enhancement-mode power transistor in Dual Flat No-lead Package (DFN) with 8 mm × 8 mm size. The properties of GaN allow for high current, high breakdown voltage and high switching frequency.

Features

- 650V GaN enhancement-mode power switch
- $R_{DS(on),\ max}$ 65mΩ
- Recommended gate drive voltage 0V ~ 6V
- Ultra-low FOM
- Ultra-high switching frequency
- Reverse current capability
- Zero reverse recovery loss
- Monolithic integrated ESD protection, HBM class 2, CDM class C3
- RoHS, Pb-free, REACH-compliant

Applications

- AC-DC converters, DC-DC converters
- Bridgeless totem pole PFC, data center, telecom, network SMPS
- Uninterruptable power supplies (UPS)
- Solar inverters, energy storage systems
- Wireless power transfer
- Power adapters, LED lighting drivers
- Laser drivers
- Industrial motor drives

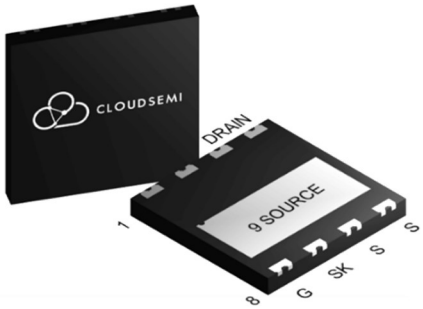


Table 1 Key Performance Parameters at T_j = 25 °C

Parameters	Values	Units
$V_{DS,\ max}$	650	V
$R_{DS(on),\ max}$	65	mΩ
$Q_{G,\ typ}$	6.5	nC
$I_{D,\ Pulse}$	60	A
Q_{OSS} @ 400 V	60	nC
Q_{rr}	0	nC

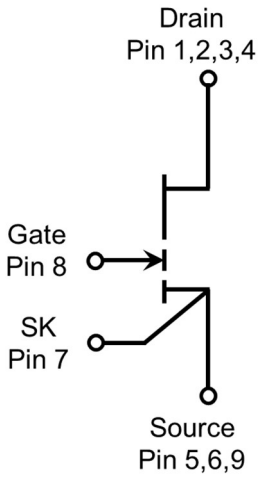


Table 2 Ordering Information

Ordering Code	Package	Marking	Packing
CG65065DAD	DFN 8x8	CG65065DAD	Reel

Table of Contents

1 Maximum ratings

at T_j = 25 °C unless otherwise specified. Continuous application of maximum ratings can deteriorate transistor lifetime. For further information, contact CloudSemi sales office.

Table 3 Maximum ratings

Parameters	Sym.	Values			Units	Notes/Test Conditions
		Min.	Typ.	Max.		
Drain-source voltage	$V_{DS, max}$	-	-	650	V	V_{GS} = 0 V; I_D = 10 μA
Drain-source voltage transient [1]	$V_{DS, transient}$	-	-	850	V	V_{GS} = 0 V; V_{DS} = 850 V
Continuous current, drain-source	I_D	-	-	30	A	T_c = 25 °C
Pulsed current, drain-source [2]	$I_{D, pulse}$	-	-	60	A	T_c = 25 °C; V_G = 6 V
Pulsed current, drain-source [2]	$I_{D, pulse}$	-	-	25	A	T_c = 150 °C; V_G = 6 V
Gate-source voltage, continuous [3]	V_{GS}	-7	-	+7	V	T_j = -55 °C to 150 °C
Gate-source voltage, pulsed	$V_{GS, pulse}$	-20	-	+10	V	T_j = -55 °C to 150 °C; t_{Pulse} = 50 ns; f = 100 kHz; open drain
Power dissipation	P_{tot}	-	-	152	W	T_c = 25 °C
Operating temperature	T_j	-55	-	+150	°C	
Storage temperature	T_{stg}	-55	-	+150	°C	

1. $V_{DS, transient}$ is intended for surge rating during non-repetitive events, t_{Pulse} < 1 μs.
2. Pulse width = 10 μs.
3. The minimum V_{GS} is clamped by ESD protection circuit, as shown in Figure 8.

2 Thermal characteristics

Table 4 Thermal characteristics

Parameters	Sym.	Values			Units	Notes/Test Conditions
		Min.	Typ.	Max.		
Thermal resistance, junction-case	R_{thJC}	-	-	0.82	°C/W	
Thermal resistance, junction-ambient [1]	R_{thJA}	-	-	45	°C/W	
Reflow soldering temperature	T_{sold}	-	-	260	°C	MSL3

1. Device mounted on 1.6 mm PCB thickness FR4, 4-layer PCB with 2 oz copper on each layer. The recommendation for thermal vias under the thermal pad is 0.3 mm diameter (12mil) with 0.889 mm pitch (35mil). The copper layers under the thermal pad and drain pad are 25 x 25 mm^2 each. The PCB is mounted in horizontal position without air stream cooling.

3 Electrical characteristics

at T_j = 25 °C, unless otherwise specified.

Table 5 Static characteristics

Parameters	Sym.	Values			Units	Notes/Test Conditions
		Min.	Typ.	Max.		
Gate threshold voltage	$V_{GS(TH)}$	1.1	1.7	2.6	V	I_D = 7.3 mA; V_{DS} = V_{GS}; T_j = 25 °C
		-	1.9	-		I_D = 7.3 mA; V_{DS} = V_{GS}; T_j = 150 °C
Drain-source leakage current	I_{DSS}	-	2	55	μA	V_{DS} = 650 V; V_{GS} = 0 V; T_j = 25 °C
		-	100	-		V_{DS} = 650 V; V_{GS} = 0 V; T_j = 150 °C
Gate-source leakage current	I_{GSS}	-	170	-	μA	V_{GS} = 6 V; V_{DS} = 0 V
Drain-source on-state resistance	$R_{DS(on)}$	-	50	65	mΩ	V_{GS} = 6 V; I_D = 9 A; T_j = 25 °C
		-	125	-	mΩ	V_{GS} = 6 V; I_D = 9 A; T_j = 150 °C
Gate resistance	R_G	-	1.6	-	Ω	f = 5 MHz; open drain

Table 6 Dynamic characteristics

Parameters	Sym.	Values			Units	Notes/Test Conditions
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	-	227	-	pF	V_{GS} = 0 V; V_{DS} = 400 V; f = 1 MHz
Output capacitance	C_{oss}	-	60	-	pF	V_{GS} = 0 V; V_{DS} = 400 V; f = 1 MHz
Reverse transfer capacitance	C_{rss}	-	0.8	-	pF	V_{GS} = 0 V; V_{DS} = 400 V; f = 1 MHz
Effective output capacitance, energy related [1]	$C_{o(er)}$	-	102	-	pF	V_{GS} = 0 V; V_{DS} = 0 to 400 V
Effective output capacitance, time related [2]	$C_{o(tr)}$	-	151	-	pF	V_{GS} = 0 V; V_{DS} = 0 to 400 V
Output charge	Q_{OSS}	-	60	-	nC	V_{GS} = 0 V; V_{DS} = 400 V; f = 1 MHz
Output Capacitance Stored Energy	E_{OSS}	-	8.2	-	μJ	
Turn-on delay time	$t_{d(on)}$	-	8.5	-	ns	V_{DS} = 400 V; I_D = 15 A; L = 90 μH; V_{GS} = 6 V; R_{on} = 10 Ω; R_{off} = 1 Ω
Turn-off delay time	$t_{d(off)}$	-	10.7	-	ns	
Rise time	t_r	-	6.4	-	ns	
Fall time	t_f	-	5.9	-	ns	
Switching Energy during turn-on	E_{on}	-	48	-	μJ	
Switching Energy during turn-off	E_{off}	-	7.8	-	μJ	

1. $C_{o(er)}$ is the fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 400 V.
2. $C_{o(tr)}$ is the fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 400 V.

Table 7 Gate charge characteristics

Parameters	Sym.	Values			Units	Notes/Test Conditions
		Min.	Typ.	Max.		
Gate charge	Q_G	-	6.3	-	nC	V_{GS} = 0 to 6 V; V_{DS} = 400 V; I_D = 30 A
Gate-source charge	Q_{GS}	-	1.6	-	nC	
Gate-drain charge	Q_{GD}	-	1.9	-	nC	
Gate plateau voltage	V_{plat}	-	2.9	-	V	V_{DS} = 400 V; I_D = 30 A

Table 8 Reverse conduction characteristics

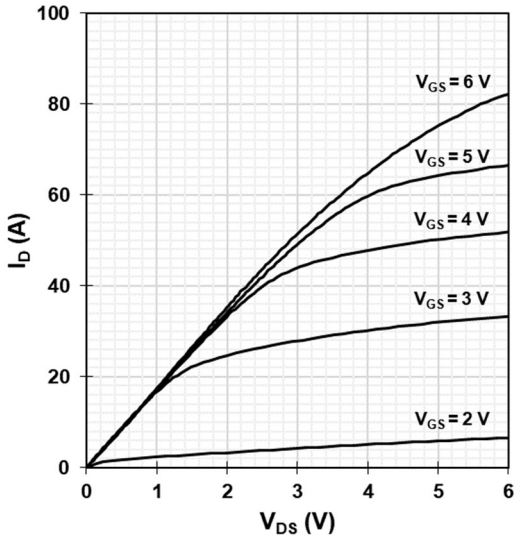
Parameters	Sym.	Values			Units	Notes/Test Conditions
		Min.	Typ.	Max.		
Source-drain reverse voltage	V_{SD}	-	2.9	-	V	V_{GS} = 0 V; I_{SD} = 15 A
Pulsed current, reverse	$I_{S,\ pulse}$	-	50	-	A	V_{GS} = 6 V
Reverse recovery charge [1]	Q_{rr}	-	0	-	nC	I_{SD} = 15 A; V_{DS} = 400 V
Reverse recovery time	t_{rr}	-	0	-	ns	
Peak reverse recovery current	I_{rrm}	-	0	-	A	

1. Excluding Q_{OSS}

4 Electrical characteristics diagrams

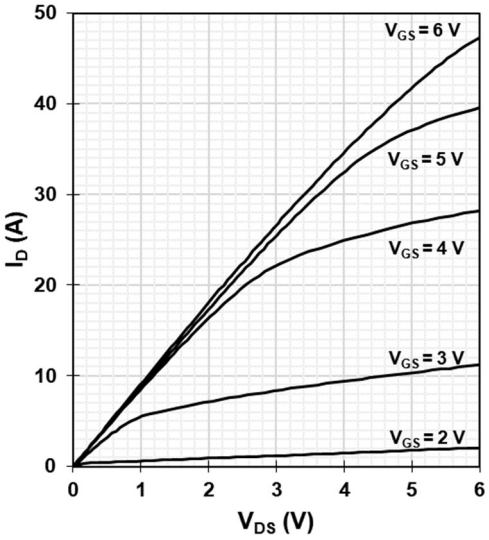
at T_j = 25 ºC, unless otherwise specified.

Figure 1 Typ. output characteristics



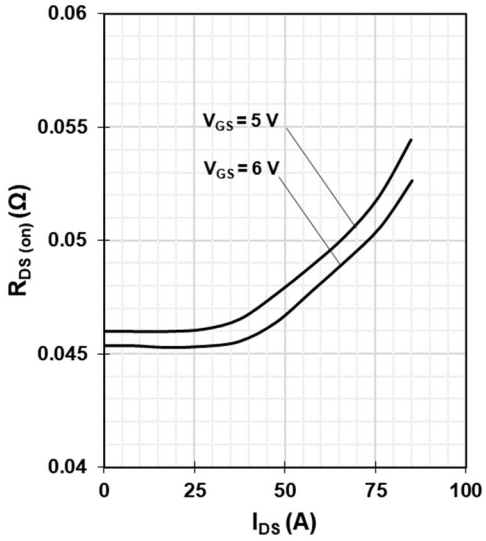
$I_D = f(V_{DS}, V_{GS})$; T_j = 25 ºC

Figure 2 Typ. output characteristics



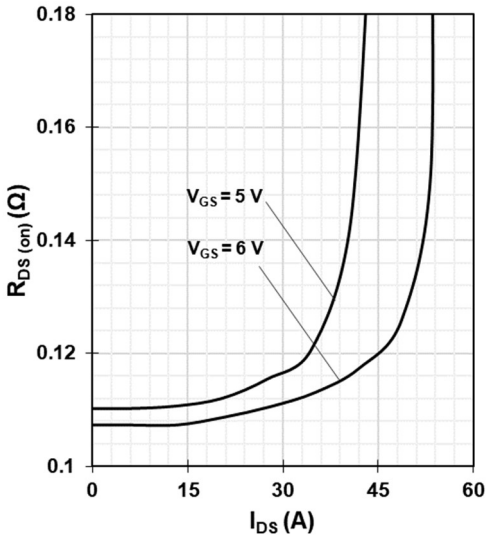
$I_D = f(V_{DS}, V_{GS})$; T_j = 150 ºC

Figure 3 Typ. drain-source on-state resistance



$R_{DS(on)} = f(I_D, V_{GS})$; T_j = 25 ºC

Figure 4 Typ. drain-source on-state resistance



$R_{DS(on)} = f(I_D, V_{GS})$; T_j = 150 ºC

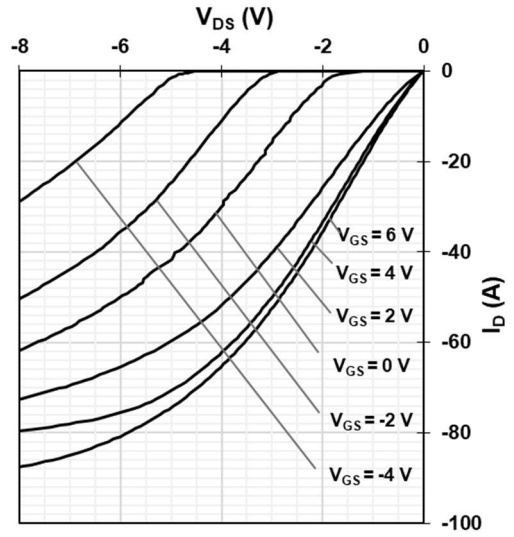
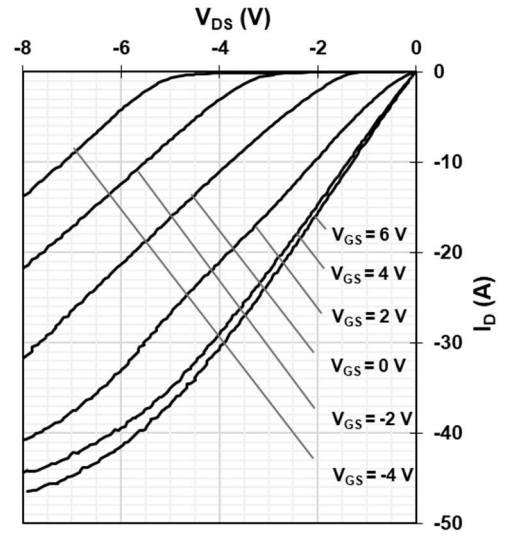
Figure 5 Typ. channel reverse characteristics	Figure 6 Typ. channel reverse characteristics
	
$I_D = f(V_{DS}, V_{GS})$; T_j = 25 °C	$I_D = f(V_{DS}, V_{GS})$; T_j = 150 °C

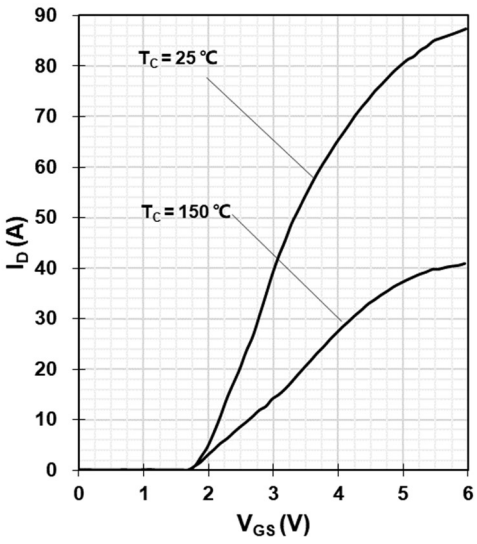
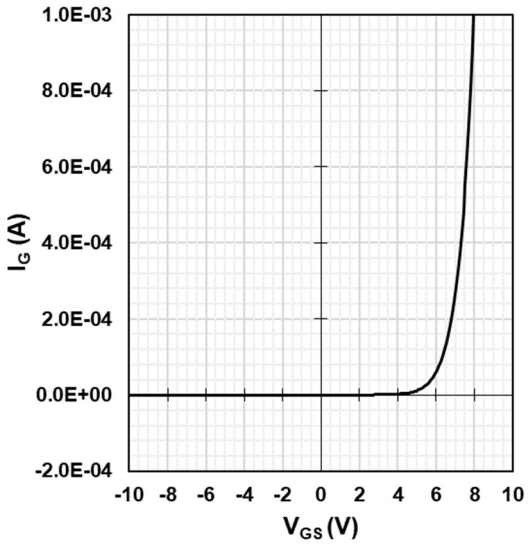
Figure 7 Typ. transfer characteristics	Figure 8 Typ. gate-to-source leakage
	
$I_D = f(V_{GS})$; V_{DS} = 5 V	$I_G = f(V_{GS})$; V_D = open

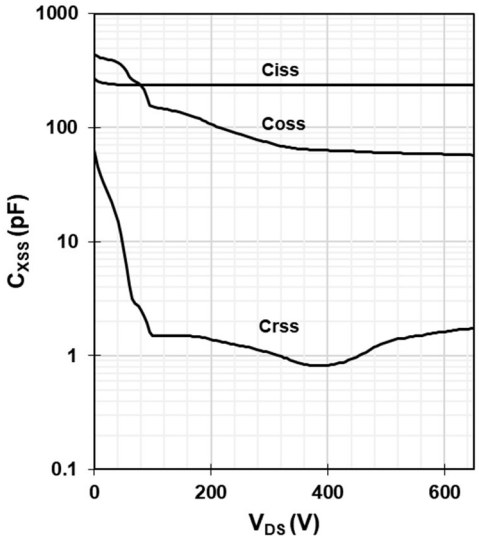
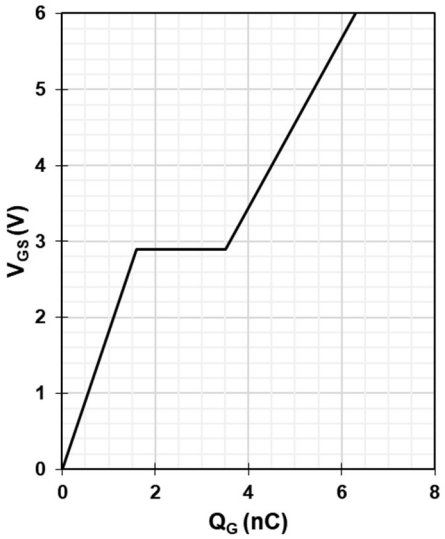
Figure 9 Typ. capacitances	Figure 10 Typ. gate charge
	
C_{XSS} = f(V_{DS}); Freq. = 1 MHz	V_{GS} = f(Q_G); V_{DS} = 400 V; I_D = 30 A

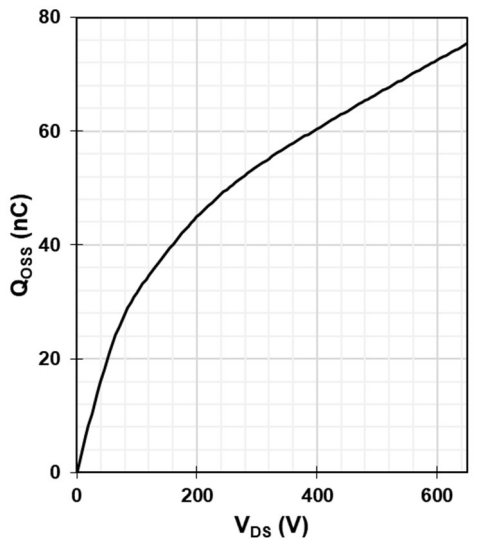
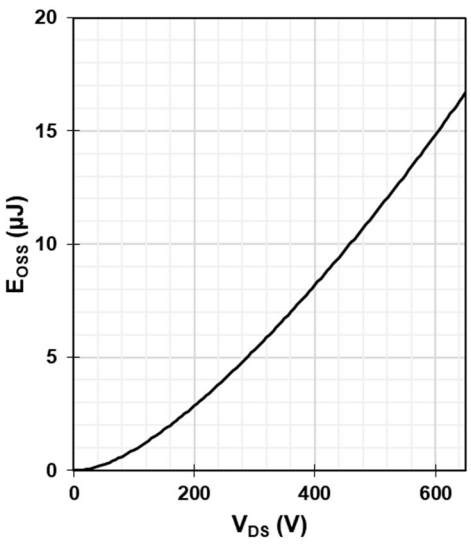
Figure 11 Typ. output charge	Figure 12 Typ. C_{oss} stored energy
	
Q_{OSS} = f(V_{DS}); Freq. = 1 MHz	E_{OSS} = f(V_{DS}); Freq. = 1 MHz

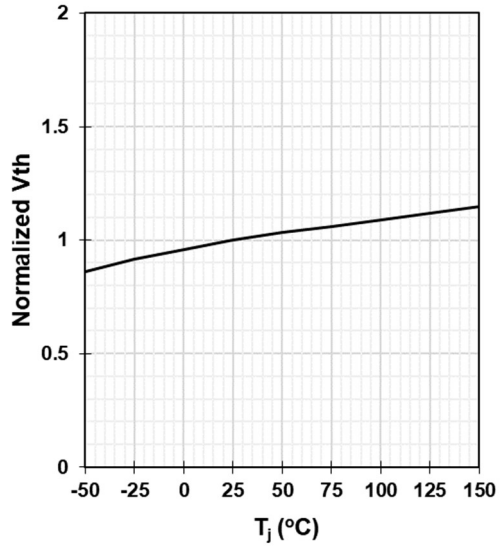
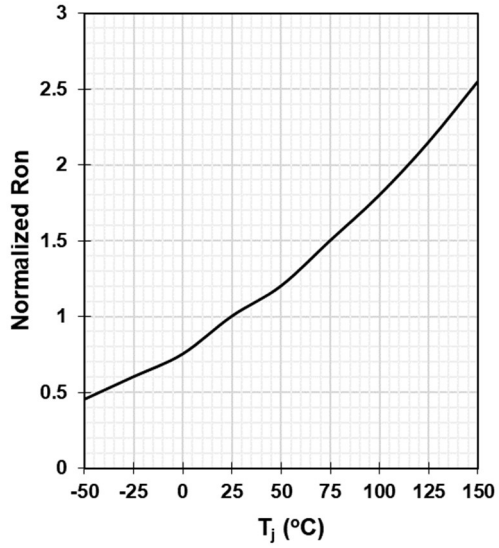
Figure 13 Gate threshold voltage	Figure 14 Drain-source on-state resistance
	
$V_{GS(TH)} = f(T_j)$; $V_{GS} = V_{DS}$; I_D = 7.3 mA	$R_{DS(on)} = f(T_j)$; I_D = 5.3 A; V_{GS} = 6 V

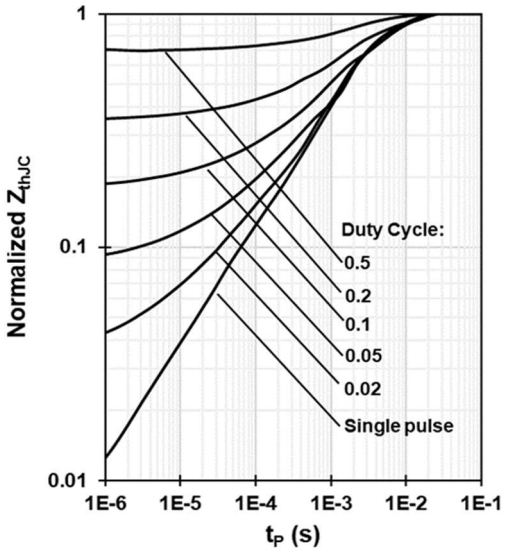
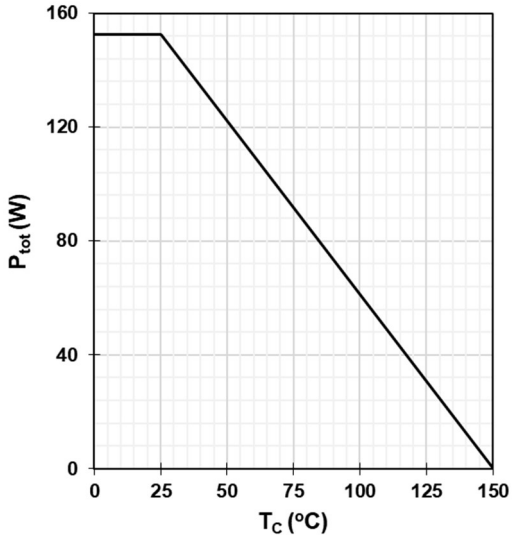
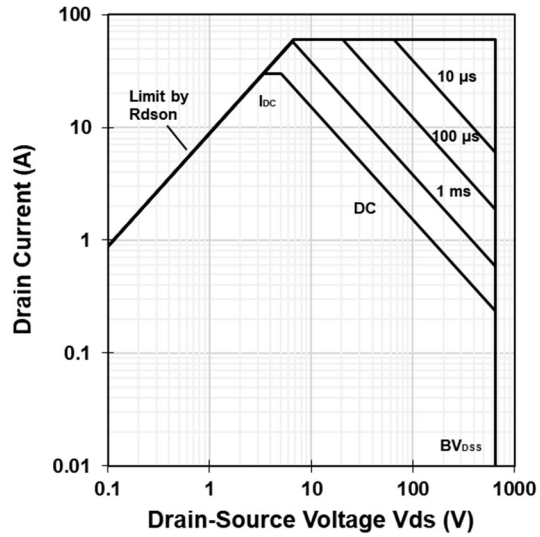
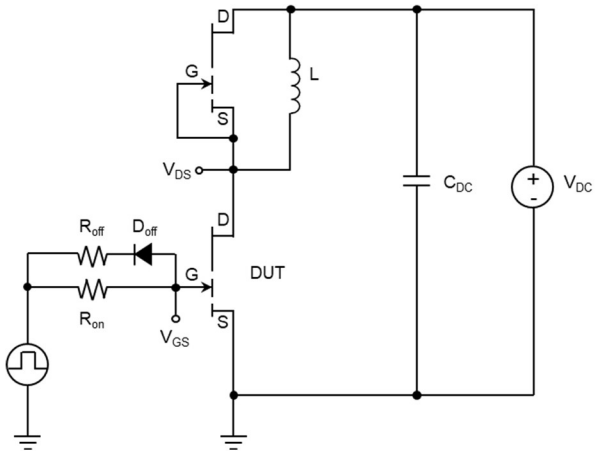
Figure 15 Max. transient thermal impedance	Figure 16 Power dissipation
	
$Z_{thJC} = f(t_P, D)$	$P_{tot} = f(T_C)$

Figure 17 Safe operating area



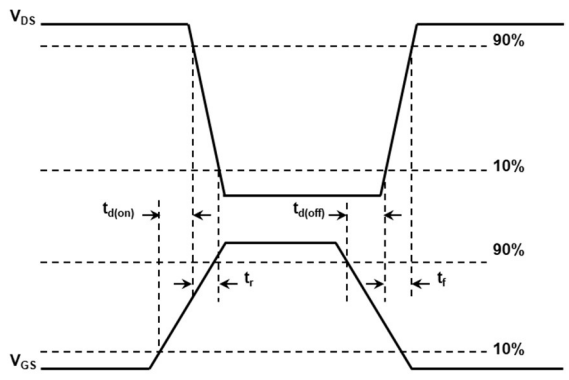
$I_D = f(V_{DS})$; $T_C = 25$ °C

Figure 18 Switching time test circuit

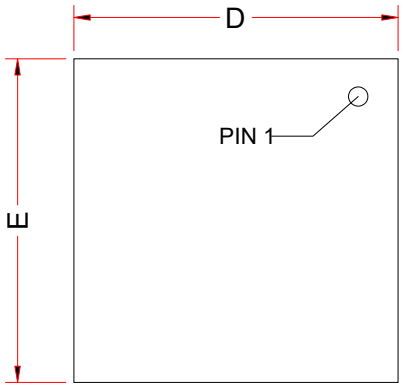


V_{DS} = 400 V, I_D = 15 A, L = 90 µH, V_{GS} = 6 V,
R_{on} = 10 Ω, R_{off} = 1 Ω

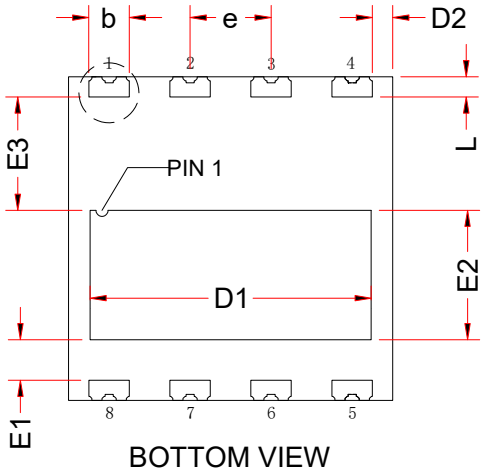
Figure 19 Typ. switching time waveform



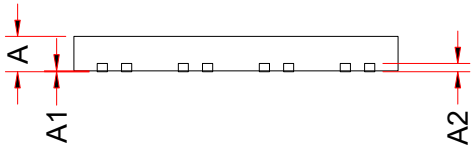
5 Package outlines



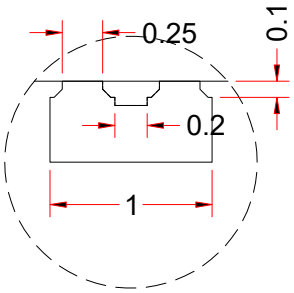
TOP VIEW



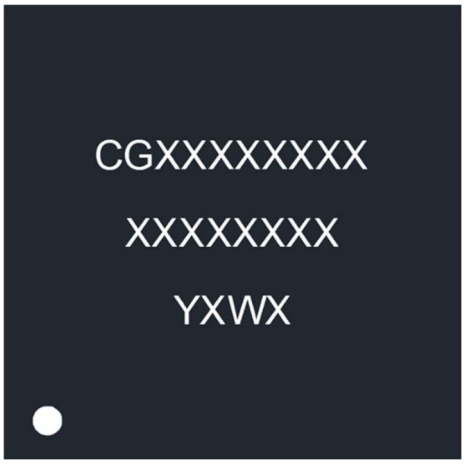
BOTTOM VIEW



SIDE VIEW



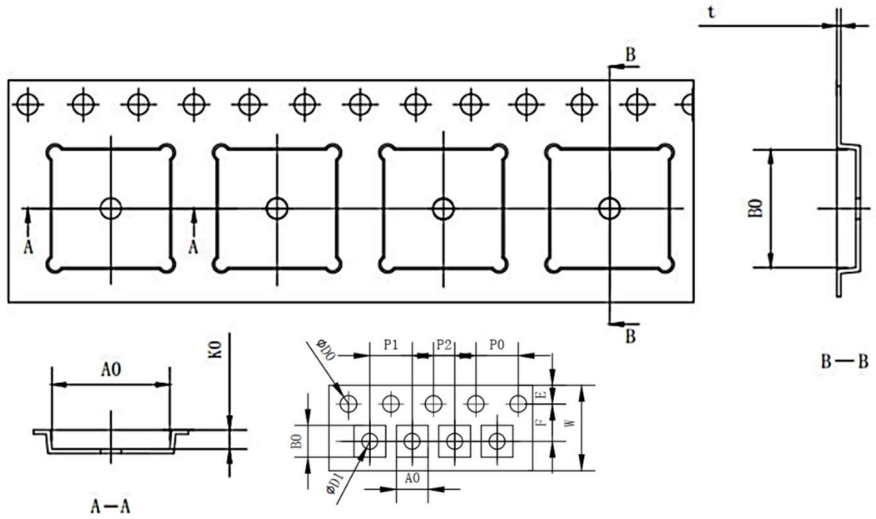
LEAD DETAIL



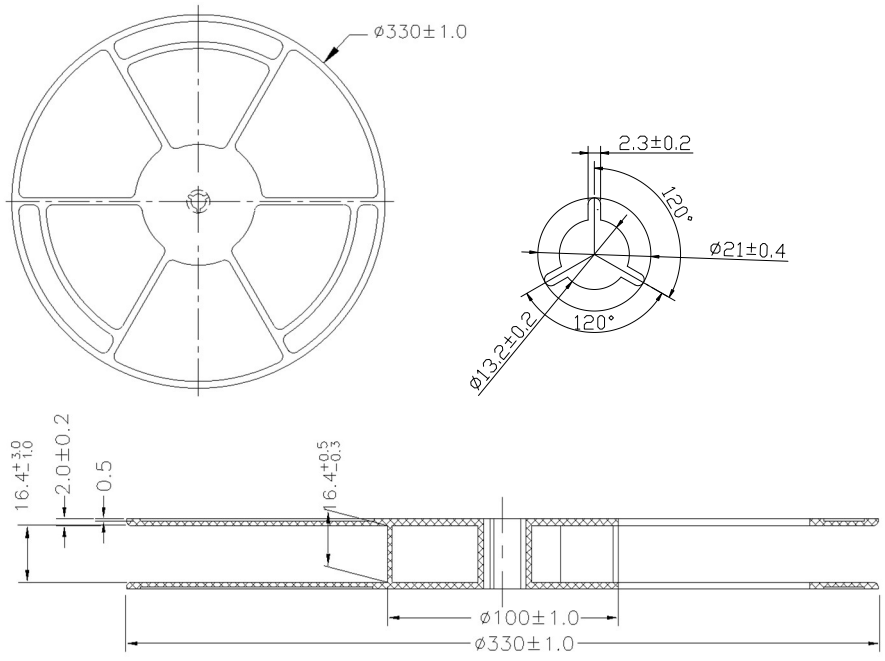
Row	Description	Example
Row 1	Device name	CGXXXXXXXX
Row 2	ASSY lot No.	XXXXXXXX
Row 3	Year & Week	YXWX

	MIN	MID	MAX
A	0.75	0.85	0.95
A1	0.00	0.02	0.05
A2		0.203REF	
b	0.95	1.00	1.05
D		8.00BSC	
D1	6.84	6.94	7.04
D2	0.40	0.50	0.60
E		8.00BSC	
E1	0.90	1.00	1.10
E2	3.10	3.20	3.30
E3	2.70	2.80	2.90
e		2.00BSC	
L	0.40	0.50	0.60

6 Reel information



SYMBOL	DIMENSION	SYMBOL	DIMENSION
W	16.00±0.30	10P0	40.00±0.20
E	1.75±0.10	P1	12.00±0.10
F	7.50±0.10	A0	8.30±0.10
D0	1.50±0.10	B0	8.30±0.10
D1	1.50±0.10	K0	1.10±0.10
P0	4.00±0.10	t	0.30±0.05
P2	2.00±0.10		



7 Revision history

Major changes since the last revision.

Revision	Date	Description of changes
1.0	2024-04-16	1.0 version release